

# SKM200GAL12F4SiC3



SEMITRANS® 3

## High Speed IGBT4 Modules

### SKM200GAL12F4SiC3

#### Features\*

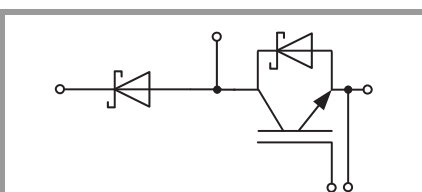
- IGBT4 = 4. Generation Fast Trench (High Speed) IGBT (Infineon)
- With Silicon Carbide Schottky diodes (ROHM)
- Insulated copper baseplate using DBC Technology (Direct Bonded Copper)
- UL recognized, file no. E63532
- With integrated gate resistor
- For higher switching frequencies

#### Typical Applications

- AC inverter drives
- UPS
- Electronic welders
- DC/DC converters

#### Remarks

- Case temperature limited to  $T_c = 125^\circ\text{C}$  max.
- Recommended  $T_{op} = -40 \dots +150^\circ\text{C}$
- Product reliability results valid for  $T_j = 150^\circ\text{C}$



GAL

Absolute Maximum Ratings				
Symbol	Conditions		Values	Unit
IGBT				
V <sub>CES</sub>	T <sub>J</sub> = 25 °C		1200	V
I <sub>C</sub>	T <sub>J</sub> = 175 °C	T <sub>c</sub> = 25 °C	312	A
		T <sub>c</sub> = 80 °C	239	A
I <sub>Cnom</sub>			200	A
I <sub>CRM</sub>			400	A
V <sub>GES</sub>			-20 ... 20	V
t <sub>psc</sub>	V <sub>CC</sub> = 800 V V <sub>GE</sub> ≤ 15 V V <sub>CES</sub> ≤ 1200 V R <sub>G on/off</sub> ≥ 2 Ω	T <sub>J</sub> = 150 °C	10	μs
T <sub>J</sub>			-40 ... 175	°C
Inverse diode				
I <sub>F</sub>	T <sub>J</sub> = 175 °C	T <sub>c</sub> = 25 °C	123	A
		T <sub>c</sub> = 80 °C	93	A
I <sub>FRM</sub>			168	A
I <sub>FSM</sub>	t <sub>p</sub> = 8.3 ms, sin 180°, T <sub>J</sub> = 25 °C		295	A
T <sub>J</sub>			-40 ... 175	°C
Freewheeling diode				
I <sub>F</sub>	T <sub>J</sub> = 175 °C	T <sub>c</sub> = 25 °C	123	A
		T <sub>c</sub> = 80 °C	93	A
I <sub>FRM</sub>			168	A
I <sub>FSM</sub>	t <sub>p</sub> = 8.3 ms, sin 180°, T <sub>J</sub> = 25 °C		295	A
T <sub>J</sub>			-40 ... 175	°C
Module				
I <sub>t(RMS)</sub>			500	A
T <sub>stg</sub>			-40 ... 125	°C
V <sub>isol</sub>	AC sinus 50 Hz, t = 1 min		4000	V

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
IGBT						
V <sub>CE(sat)</sub>	I <sub>C</sub> = 200 A	T <sub>j</sub> = 25 °C		2.06	2.42	V
	V <sub>GE</sub> = 15 V chipelevel	T <sub>j</sub> = 150 °C		2.59	2.97	V
V <sub>CE0</sub>	chipelevel	T <sub>j</sub> = 25 °C		1.10	1.28	V
		T <sub>j</sub> = 150 °C		0.95	1.13	V
r <sub>CE</sub>	V <sub>GE</sub> = 15 V chipelevel	T <sub>j</sub> = 25 °C		4.8	5.7	mΩ
		T <sub>j</sub> = 150 °C		8.2	9.2	mΩ
V <sub>GE(th)</sub>	V <sub>GE</sub> =V <sub>CE</sub> , I <sub>C</sub> = 7.6 mA		5.1	5.8	6.4	V
I <sub>CES</sub>	V <sub>GE</sub> = 0 V	T <sub>j</sub> = 25 °C			2.7	mA
	V <sub>CE</sub> = 1200 V	T <sub>j</sub> = 150 °C		-		mA
C <sub>ies</sub>	V <sub>CE</sub> = 25 V V <sub>GE</sub> = 0 V	f = 1 MHz		12.3		nF
C <sub>oes</sub>		f = 1 MHz		0.81		nF
C <sub>res</sub>		f = 1 MHz		0.69		nF
Q <sub>G</sub>	V <sub>GE</sub> = - 8 V...+ 15 V			1134		nC
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			2.4		Ω



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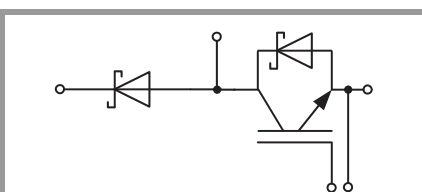
#### Typical Applications

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- UPS
- Electronic welders
- DC/DC converters

#### Remarks

- Case temperature limited to  $T_c = 125^\circ\text{C}$  max.
- Recommended  $T_{op} = -40 \dots +150^\circ\text{C}$
- Product reliability results valid for  $T_j = 150^\circ\text{C}$

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
t <sub>d(on)</sub>	V <sub>CC</sub> = 600 V	T <sub>j</sub> = 150 °C		140		ns
t <sub>r</sub>	I <sub>C</sub> = 200 A	T <sub>j</sub> = 150 °C		30		ns
E <sub>on</sub>	V <sub>GE</sub> = +15/-15 V	T <sub>j</sub> = 150 °C		3.5		mJ
t <sub>d(off)</sub>	R <sub>G on</sub> = 1 Ω	T <sub>j</sub> = 150 °C		340		ns
t <sub>f</sub>	R <sub>G off</sub> = 1 Ω	T <sub>j</sub> = 150 °C		60		ns
E <sub>off</sub>	di/dt <sub>on</sub> = 7100 A/μs di/dt <sub>off</sub> = 2850 A/μs	T <sub>j</sub> = 150 °C		14		mJ
R <sub>th(j-c)</sub>	per IGBT				0.115	K/W
Inverse diode						
V <sub>F</sub> = V <sub>EC</sub>	I <sub>F</sub> = 80 A	T <sub>j</sub> = 25 °C		1.40	1.60	V
	V <sub>GE</sub> = 0 V chipelevel	T <sub>j</sub> = 150 °C		1.79	2.10	V
V <sub>F0</sub>	chipelevel	T <sub>j</sub> = 25 °C		0.95	1.05	V
		T <sub>j</sub> = 150 °C		0.83	0.90	V
r <sub>F</sub>	chipelevel	T <sub>j</sub> = 25 °C		5.6	6.9	mΩ
		T <sub>j</sub> = 150 °C		12	15	mΩ
C <sub>j</sub>	parallel to C <sub>oss</sub> , f = 1 MHz, V <sub>R</sub> = 800 V, T <sub>j</sub> = 25 °C			0.340		nF
Q <sub>c</sub>	V <sub>R</sub> = 800 V, di/dt <sub>off</sub> = 500 A/μs, T <sub>j</sub> = 25 °C			0.26		μC
R <sub>th(j-c)</sub>	per diode				0.42	K/W
Freewheeling diode						
V <sub>F</sub> = V <sub>EC</sub>	I <sub>F</sub> = 80 A	T <sub>j</sub> = 25 °C		1.40	1.60	V
	V <sub>GE</sub> = 0 V chipelevel	T <sub>j</sub> = 150 °C		1.79	2.10	V
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Q <sub>c</sub>	V <sub>R</sub> = 800 V, di/dt <sub>off</sub> = 500 A/μs, T <sub>j</sub> = 25 °C			0.26		μC
R <sub>th(j-c)</sub>	per diode				0.42	K/W
Module						
L <sub>CE</sub>				15		nH
R <sub>CC'+EE'</sub>	measured per switch	T <sub>C</sub> = 25 °C		0.55		mΩ
		T <sub>C</sub> = 125 °C		0.85		mΩ
R <sub>th(c-s)</sub>	calculated without thermal coupling (λ <sub>grease</sub> =0.81 W/(m²K))			0.02	0.038	K/W
M <sub>s</sub>	to heat sink M6		3		5	Nm
M <sub>t</sub>		to terminals M6	2.5		5	Nm
						Nm
w					325	g



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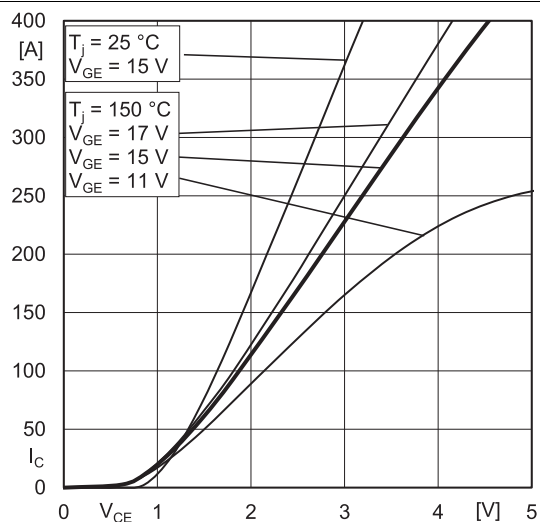


Fig. 1: Typ. output characteristic, inclusive  $R_{CC'} + E_{E'}$

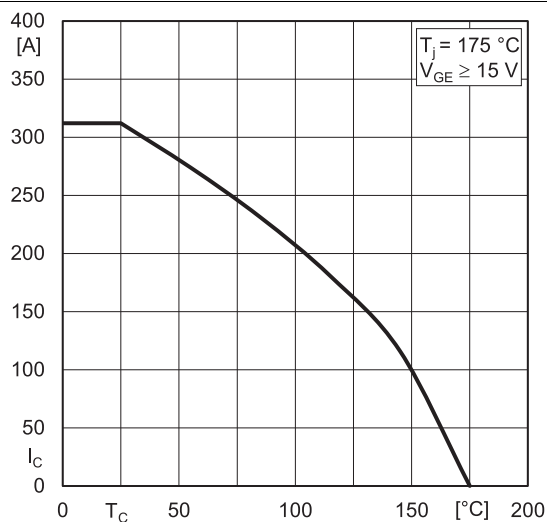


Fig. 2: Rated current vs. temperature  $I_C = f(T_C)$

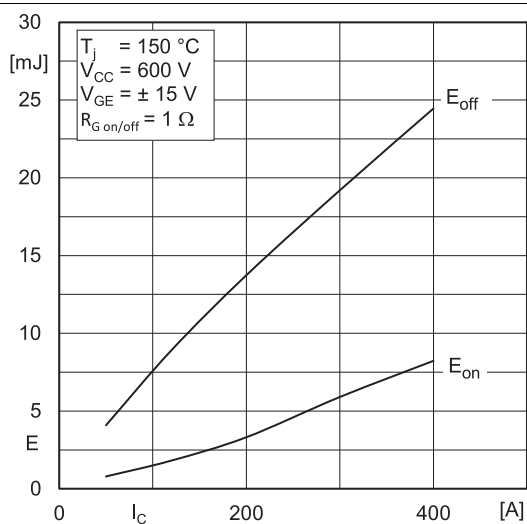


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$

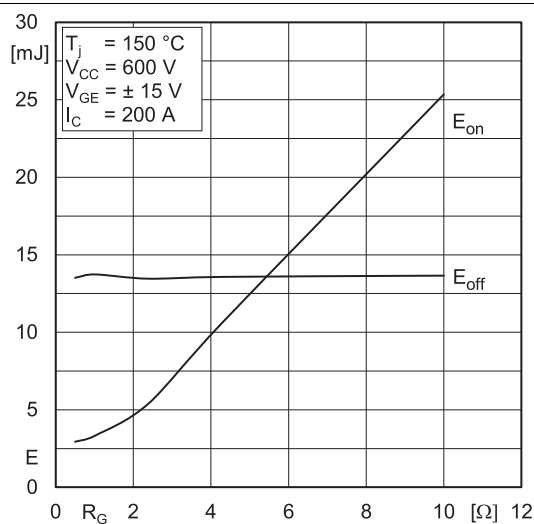


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$

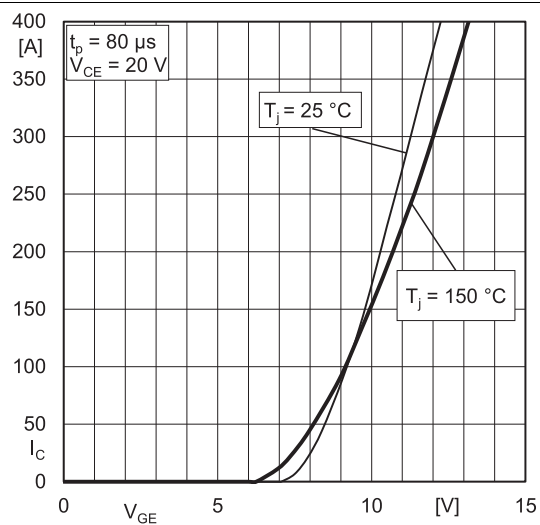


Fig. 5: Typ. transfer characteristic

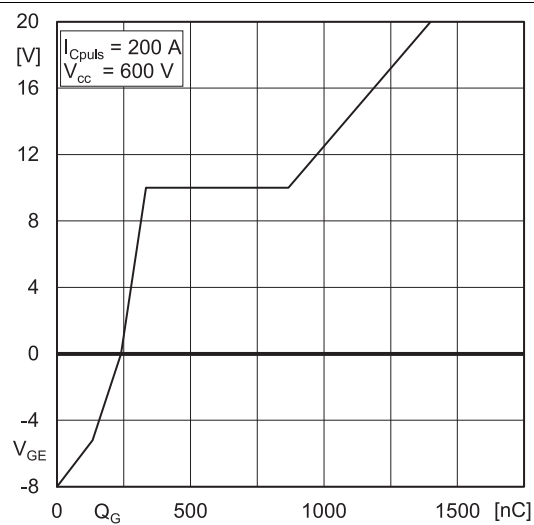


Fig. 6: Typ. gate charge characteristic

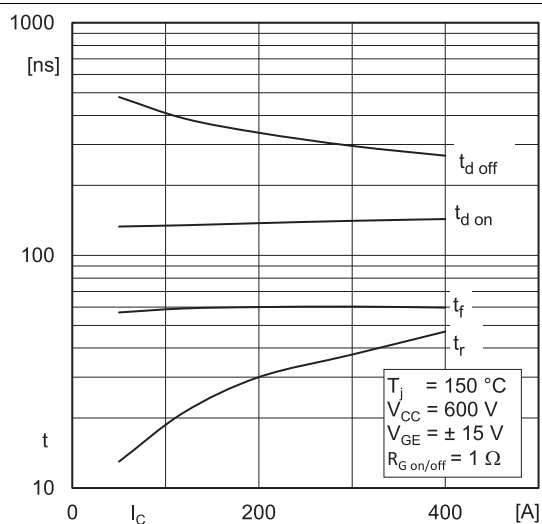


Fig. 7: Typ. switching times vs.  $I_C$

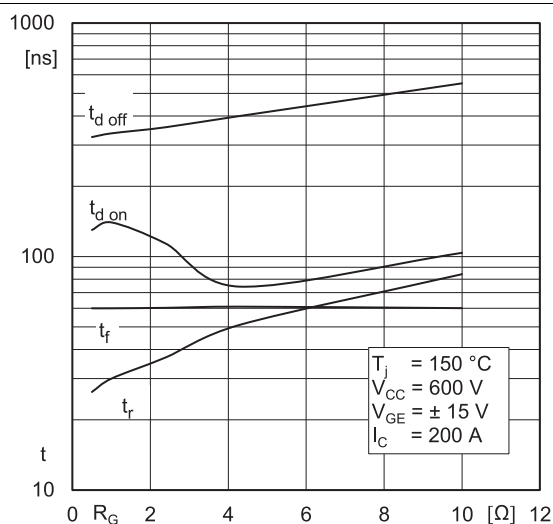


Fig. 8: Typ. switching times vs. gate resistor  $R_G$

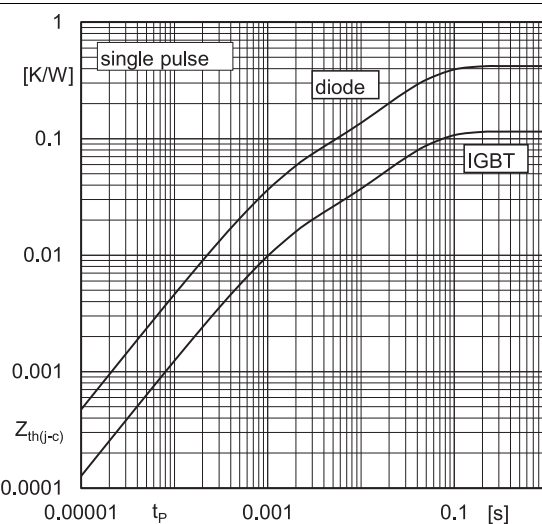


Fig. 9: Transient thermal impedance

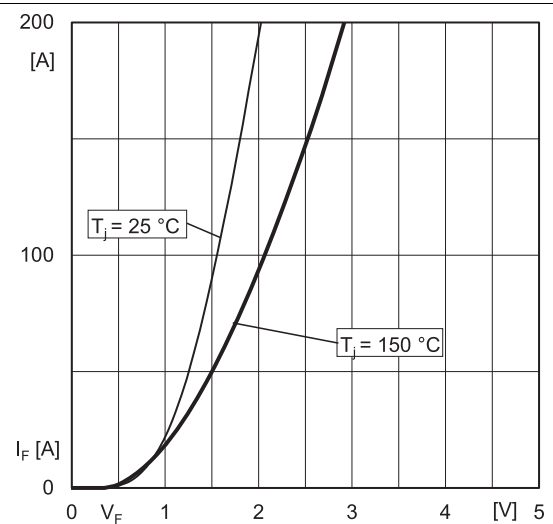
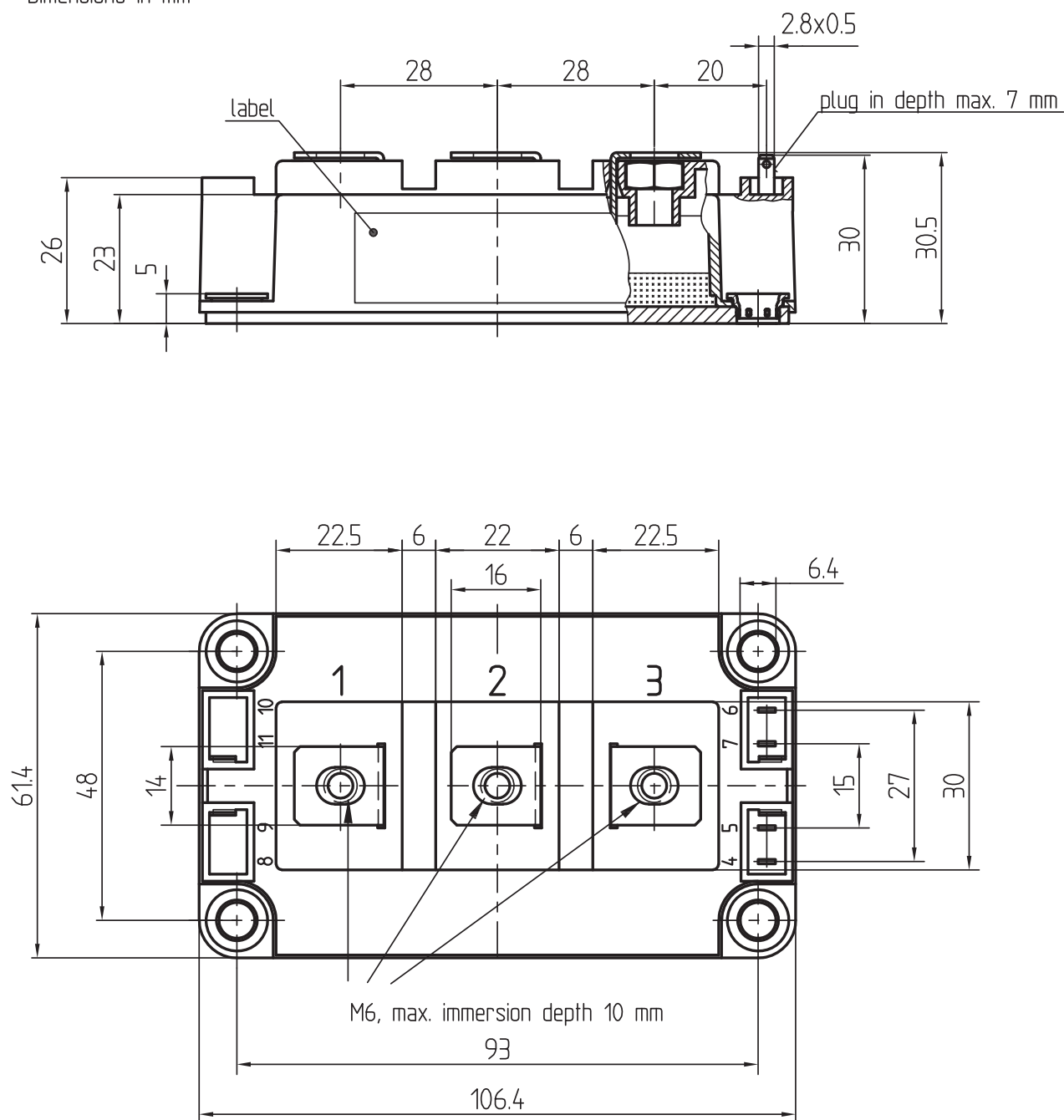


Fig. 10: Typ. Diode forward charact., incl.  $R_{CC'+EE'}$

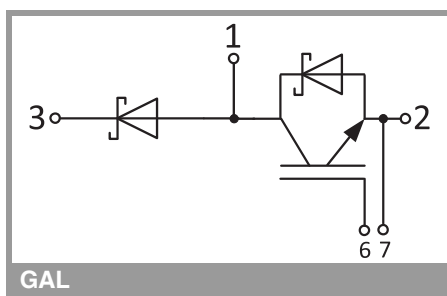
# SKM200GAL12F4SiC3

Dimensions in mm



General tolerance +/- 0.5 mm

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This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

## **\*IMPORTANT INFORMATION AND WARNINGS**

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